

# AN78Lxx/AN78LxxM Series

## 3-pin positive output voltage regulator (100 mA type)

### Overview

The AN78Lxx series and the AN78LxxM series are 3-pin fixed positive output type monolithic voltage regulator.

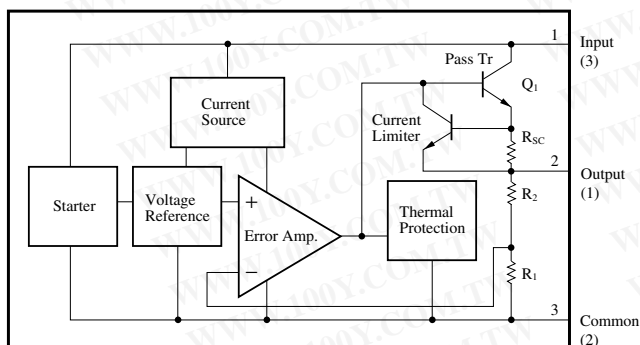
A stabilized fixed output voltage is obtained from an unstable DC input voltage without using any external parts. 12 types of fixed output voltage are available; 4V, 5V, 6V, 7V, 8V, 9V, 10V, 12V, 15V, 18V, 20V and 24V. They can be used widely as power circuits with a current capacity of up to 100mA.

### Features

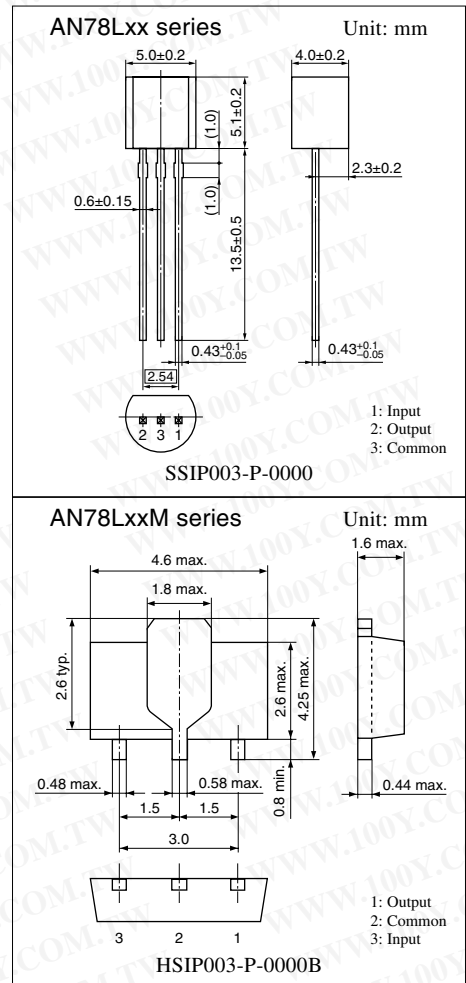
- No external components
- Output voltage: 4V, 5V, 6V, 7V, 8V, 9V, 10V, 12V, 15V, 18V, 20V, 24V
- Built-in overcurrent limit circuit
- Built-in thermal overload protection circuit

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### Block Diagram (AN78Lxx series)



(Note) The number in ( ) shows the pin number for the AN78LxxM series.



(Note) The packages (SSIP003-P-0000 and HSIP003-P-0000B) of this product will be changed to lead-free type (SSIP003-P-0000S and HSIP003-P-0000Q). See the new package dimensions section later of this datasheet.

### ■ Absolute Maximum Ratings at $T_a = 25^\circ\text{C}$

| Parameter                     |                 | Symbol    | Rating      | Unit             |
|-------------------------------|-----------------|-----------|-------------|------------------|
| Input voltage                 |                 | $V_I$     | 35 *1       | V                |
|                               |                 |           | 40 *2       | V                |
| Power dissipation             |                 | $P_D$     | 650 *3      | mW               |
| Operating ambient temperature |                 | $T_{opr}$ | -30 to +80  | $^\circ\text{C}$ |
| Storage temperature           | AN78Lxx series  | $T_{stg}$ | -55 to +150 | $^\circ\text{C}$ |
|                               | AN78LxxM series |           | -55 to +125 |                  |

\*1 AN78L04/M, AN78L05/M, AN78L06/M, AN78L07/M, AN78L08/M, AN78L09/M, AN78L10/M, AN78L12/M, AN78L15/M

\*2 AN78L18/M, AN78L20/M, AN78L24/M

\*3 Follow the derating curve. When  $T_j$  exceeds  $150^\circ\text{C}$ , the internal circuit cuts off the output.

AN78LxxM series is mounted on a standard board (glass epoxy: 20mm × 20mm × t1.7mm with Cu foil of 1cm<sup>2</sup> or more).

### ■ Electrical Characteristics at $T_a = 25^\circ\text{C}$

#### • AN78L04, AN78L04M (4V type)

| Parameter                               | Symbol                | Conditions   | Min  | Typ  | Max  | Unit                 |
|---|-----------------------|--|------|------|------|----------------------|
| Output voltage                          | $V_O$                 | $T_j = 25^\circ\text{C}$                                   | 3.84 | 4    | 4.16 | V                    |
| Output voltage tolerance                | $V_O$                 | $V_I = 6.5$ to 19V, $I_O = 1$ to 70mA                      | 3.8  | —    | 4.2  | V                    |
| Line regulation                         | $REG_{IN}$            | $V_I = 6.5$ to 19V, $T_j = 25^\circ\text{C}$               | —    | 50   | 145  | mV                   |
|   |                       | $V_I = 7$ to 19V, $T_j = 25^\circ\text{C}$                 | —    | 40   | 95   | mV                   |
| Load regulation                         | $REG_L$               | $I_O = 1$ to 100mA, $T_j = 25^\circ\text{C}$               | —    | 10   | 55   | mV                   |
|   |                       | $I_O = 1$ to 40mA, $T_j = 25^\circ\text{C}$                | —    | 4.5  | 30   | mV                   |
| Bias current                            | $I_{Bias}$            | $T_j = 25^\circ\text{C}$                                   | —    | 2    | 3    | mA                   |
| Bias current fluctuation to input       | $\Delta I_{Bias(IN)}$ | $V_I = 7$ to 19V, $T_j = 25^\circ\text{C}$                 | —    | —    | 1    | mA                   |
| Bias current fluctuation to load        | $\Delta I_{Bias(L)}$  | $I_O = 1$ to 40mA, $T_j = 25^\circ\text{C}$                | —    | —    | 0.1  | mA                   |
| Output noise voltage                    | $V_{no}$              | $f = 10\text{Hz}$ to 100kHz                                | —    | 40   | —    | $\mu\text{V}$        |
| Ripple rejection ratio                  | RR                    | $V_I = 7$ to 17V, $I_O = 40\text{mA}$ , $f = 120\text{Hz}$ | 48   | 58   | —    | dB                   |
| Minimum input/output voltage difference | $V_{DIF(min)}$        | $T_j = 25^\circ\text{C}$                                   | —    | 1.7  | —    | V                    |
| Output short-circuit current            | $I_{O(Short)}$        | $T_j = 25^\circ\text{C}$ , $V_I = 35\text{V}$              | —    | 140  | —    | mA                   |
| Output voltage temperature coefficient  | $\Delta V_O/T_a$      | $I_O = 5\text{mA}$ , $T_j = 0$ to $125^\circ\text{C}$      | —    | -0.6 | —    | mV/ $^\circ\text{C}$ |

Note 1) The specified condition  $T_j = 25^\circ\text{C}$  means that the test should be carried out within so short a test time (within 10ms) that the characteristic value drift due to the chip junction temperature rise can be ignored.

Note 2) Unless otherwise specified,  $V_I = 9\text{V}$ ,  $I_O = 40\text{mA}$ ,  $C_1 = 0.33\mu\text{F}$ ,  $C_0 = 0.1\mu\text{F}$ ,  $T_j = 0$  to  $125^\circ\text{C}$  (AN78L04) and  $T_j = 0$  to  $100^\circ\text{C}$  (AN78L04M)

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### ■ Electrical Characteristics at $T_a = 25^\circ\text{C}$ (continued)

#### • AN78L05, AN78L05M (5V type)

| Parameter                               | Symbol                       | Conditions   | Min  | Typ   | Max  | Unit                       |
|---|------------------------------|--|------|-------|------|----------------------------|
| Output voltage                          | $V_O$                        | $T_j = 25^\circ\text{C}$   | 4.8  | 5     | 5.2  | V                          |
| Output voltage tolerance                | $V_O$                        | $V_I = 7.5$ to $20\text{V}$ , $I_O = 1$ to $70\text{mA}$             | 4.75 | —     | 5.25 | V                          |
| Line regulation                         | $\text{REG}_{\text{IN}}$     | $V_I = 7.5$ to $20\text{V}$ , $T_j = 25^\circ\text{C}$               | —    | 55    | 150  | mV                         |
|   |                              | $V_I = 8$ to $20\text{V}$ , $T_j = 25^\circ\text{C}$                 | —    | 45    | 100  | mV                         |
| Load regulation                         | $\text{REG}_{\text{L}}$      | $I_O = 1$ to $100\text{mA}$ , $T_j = 25^\circ\text{C}$               | —    | 11    | 60   | mV                         |
|   |                              | $I_O = 1$ to $40\text{mA}$ , $T_j = 25^\circ\text{C}$                | —    | 5     | 30   | mV                         |
| Bias current                            | $I_{\text{Bias}}$            | $T_j = 25^\circ\text{C}$   | —    | 2     | 3    | mA                         |
| Bias current fluctuation to input       | $\Delta I_{\text{Bias(IN)}}$ | $V_I = 8$ to $20\text{V}$ , $T_j = 25^\circ\text{C}$                 | —    | —     | 1    | mA                         |
| Bias current fluctuation to load        | $\Delta I_{\text{Bias(L)}}$  | $I_O = 1$ to $40\text{mA}$ , $T_j = 25^\circ\text{C}$                | —    | —     | 0.1  | mA                         |
| Output noise voltage                    | $V_{\text{no}}$              | $f = 10\text{Hz}$ to $100\text{kHz}$                                 | —    | 40    | —    | $\mu\text{V}$              |
| Ripple rejection ratio                  | RR                           | $V_I = 8$ to $18\text{V}$ , $I_O = 40\text{mA}$ , $f = 120\text{Hz}$ | 47   | 57    | —    | dB                         |
| Minimum input/output voltage difference | $V_{\text{DIF(min)}}$        | $T_j = 25^\circ\text{C}$   | —    | 1.7   | —    | V                          |
| Output short-circuit current            | $I_{\text{O(Short)}}$        | $T_j = 25^\circ\text{C}$ , $V_I = 35\text{V}$                        | —    | 140   | —    | mA                         |
| Output voltage temperature coefficient  | $\Delta V_O/T_a$             | $I_O = 5\text{mA}$ , $T_j = 0$ to $125^\circ\text{C}$                | —    | -0.65 | —    | $\text{mV}/^\circ\text{C}$ |

Note 1) The specified condition  $T_j = 25^\circ\text{C}$  means that the test should be carried out within so short a test time (within 10ms) that the characteristic value drift due to the chip junction temperature rise can be ignored.

Note 2) Unless otherwise specified,  $V_I = 10\text{V}$ ,  $I_O = 40\text{mA}$ ,  $C_1 = 0.33\mu\text{F}$ ,  $C_O = 0.1\mu\text{F}$ ,  $T_j = 0$  to  $125^\circ\text{C}$  (AN78L05) and  $T_j = 0$  to  $100^\circ\text{C}$  (AN78L05M)

#### • AN78L06, AN78L06M (6V type)

| Parameter                               | Symbol                       | Conditions   | Min  | Typ  | Max  | Unit                       |
|---|------------------------------|--|------|------|------|----------------------------|
| Output voltage                          | $V_O$                        | $T_j = 25^\circ\text{C}$   | 5.76 | 6    | 6.24 | V                          |
| Output voltage tolerance                | $V_O$                        | $V_I = 8.5$ to $21\text{V}$ , $I_O = 1$ to $70\text{mA}$             | 5.7  | —    | 6.3  | V                          |
| Line regulation                         | $\text{REG}_{\text{IN}}$     | $V_I = 8.5$ to $21\text{V}$ , $T_j = 25^\circ\text{C}$               | —    | 60   | 155  | mV                         |
|   |                              | $V_I = 9$ to $21\text{V}$ , $T_j = 25^\circ\text{C}$                 | —    | 50   | 105  | mV                         |
| Load regulation                         | $\text{REG}_{\text{L}}$      | $I_O = 1$ to $100\text{mA}$ , $T_j = 25^\circ\text{C}$               | —    | 12   | 65   | mV                         |
|   |                              | $I_O = 1$ to $40\text{mA}$ , $T_j = 25^\circ\text{C}$                | —    | 5.5  | 35   | mV                         |
| Bias current                            | $I_{\text{Bias}}$            | $T_j = 25^\circ\text{C}$   | —    | 2    | 3    | mA                         |
| Bias current fluctuation to input       | $\Delta I_{\text{Bias(IN)}}$ | $V_I = 9$ to $21\text{V}$ , $T_j = 25^\circ\text{C}$                 | —    | —    | 1    | mA                         |
| Bias current fluctuation to load        | $\Delta I_{\text{Bias(L)}}$  | $I_O = 1$ to $40\text{mA}$ , $T_j = 25^\circ\text{C}$                | —    | —    | 0.1  | mA                         |
| Output noise voltage                    | $V_{\text{no}}$              | $f = 10\text{Hz}$ to $100\text{kHz}$                                 | —    | 50   | —    | $\mu\text{V}$              |
| Ripple rejection ratio                  | RR                           | $V_I = 9$ to $19\text{V}$ , $I_O = 40\text{mA}$ , $f = 120\text{Hz}$ | 46   | 56   | —    | dB                         |
| Minimum input/output voltage difference | $V_{\text{DIF(min)}}$        | $T_j = 25^\circ\text{C}$   | —    | 1.7  | —    | V                          |
| Output short-circuit current            | $I_{\text{O(Short)}}$        | $T_j = 25^\circ\text{C}$ , $V_I = 35\text{V}$                        | —    | 140  | —    | mA                         |
| Output voltage temperature coefficient  | $\Delta V_O/T_a$             | $I_O = 5\text{mA}$ , $T_j = 0$ to $125^\circ\text{C}$                | —    | -0.7 | —    | $\text{mV}/^\circ\text{C}$ |

Note 1) The specified condition  $T_j = 25^\circ\text{C}$  means that the test should be carried out within so short a test time (within 10ms) that the characteristic value drift due to the chip junction temperature rise can be ignored.

Note 2) Unless otherwise specified,  $V_I = 11\text{V}$ ,  $I_O = 40\text{mA}$ ,  $C_1 = 0.33\mu\text{F}$ ,  $C_O = 0.1\mu\text{F}$ ,  $T_j = 0$  to  $125^\circ\text{C}$  (AN78L06) and  $T_j = 0$  to  $100^\circ\text{C}$  (AN78L06M)

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### ■ Electrical Characteristics at $T_a = 25^\circ\text{C}$ (continued)

#### • AN78L07, AN78L07M (7V type)

| Parameter                               | Symbol                       | Conditions  | Min  | Typ   | Max  | Unit                 |
|---|------------------------------|---|------|-------|------|----------------------|
| Output voltage                          | $V_O$                        | $T_j = 25^\circ\text{C}$                                    | 6.72 | 7     | 7.28 | V                    |
| Output voltage tolerance                | $V_O$                        | $V_1 = 9.5$ to 22V, $I_O = 1$ to 70mA                       | 6.65 | —     | 7.35 | V                    |
| Line regulation                         | REG <sub>IN</sub>            | $V_1 = 9.5$ to 22V, $T_j = 25^\circ\text{C}$                | —    | 70    | 165  | mV                   |
|   |                              | $V_1 = 10$ to 22V, $T_j = 25^\circ\text{C}$                 | —    | 60    | 115  | mV                   |
| Load regulation                         | REG <sub>L</sub>             | $I_O = 1$ to 100mA, $T_j = 25^\circ\text{C}$                | —    | 13    | 75   | mV                   |
|   |                              | $I_O = 1$ to 40mA, $T_j = 25^\circ\text{C}$                 | —    | 6     | 35   | mV                   |
| Bias current                            | $I_{\text{Bias}}$            | $T_j = 25^\circ\text{C}$                                    | —    | 2     | 3    | mA                   |
| Bias current fluctuation to input       | $\Delta I_{\text{Bias(IN)}}$ | $V_1 = 10$ to 22V, $T_j = 25^\circ\text{C}$                 | —    | —     | 1    | mA                   |
| Bias current fluctuation to load        | $\Delta I_{\text{Bias(L)}}$  | $I_O = 1$ to 40mA, $T_j = 25^\circ\text{C}$                 | —    | —     | 0.1  | mA                   |
| Output noise voltage                    | $V_{\text{no}}$              | $f = 10\text{Hz}$ to 100kHz                                 | —    | 50    | —    | $\mu\text{V}$        |
| Ripple rejection ratio                  | RR                           | $V_1 = 10$ to 20V, $I_O = 40\text{mA}$ , $f = 120\text{Hz}$ | 45   | 55    | —    | dB                   |
| Minimum input/output voltage difference | $V_{\text{DIF(min)}}$        | $T_j = 25^\circ\text{C}$                                    | —    | 1.7   | —    | V                    |
| Output short-circuit current            | $I_{\text{O(Short)}}$        | $T_j = 25^\circ\text{C}$ , $V_1 = 35\text{V}$               | —    | 140   | —    | mA                   |
| Output voltage temperature coefficient  | $\Delta V_O/T_a$             | $I_O = 5\text{mA}$ , $T_j = 0$ to $125^\circ\text{C}$       | —    | -0.75 | —    | mV/ $^\circ\text{C}$ |

Note 1) The specified condition  $T_j = 25^\circ\text{C}$  means that the test should be carried out within so short a test time (within 10ms) that the characteristic value drift due to the chip junction temperature rise can be ignored.

Note 2) Unless otherwise specified,  $V_1 = 12\text{V}$ ,  $I_O = 40\text{mA}$ ,  $C_1 = 0.33\mu\text{F}$ ,  $C_O = 0.1\mu\text{F}$ ,  $T_j = 0$  to  $125^\circ\text{C}$  (AN78L07) and  $T_j = 0$  to  $100^\circ\text{C}$  (AN78L07M)

#### • AN78L08, AN78L08M (8V type)

| Parameter                               | Symbol                       | Conditions  | Min | Typ  | Max | Unit                 |
|---|------------------------------|---|-----|------|-----|----------------------|
| Output voltage                          | $V_O$                        | $T_j = 25^\circ\text{C}$                                    | 7.7 | 8    | 8.3 | V                    |
| Output voltage tolerance                | $V_O$                        | $V_1 = 10.5$ to 23V, $I_O = 1$ to 70mA                      | 7.6 | —    | 8.4 | V                    |
| Line regulation                         | REG <sub>IN</sub>            | $V_1 = 10.5$ to 23V, $T_j = 25^\circ\text{C}$               | —   | 80   | 175 | mV                   |
|   |                              | $V_1 = 11$ to 23V, $T_j = 25^\circ\text{C}$                 | —   | 70   | 125 | mV                   |
| Load regulation                         | REG <sub>L</sub>             | $I_O = 1$ to 100mA, $T_j = 25^\circ\text{C}$                | —   | 15   | 80  | mV                   |
|   |                              | $I_O = 1$ to 40mA, $T_j = 25^\circ\text{C}$                 | —   | 7    | 40  | mV                   |
| Bias current                            | $I_{\text{Bias}}$            | $T_j = 25^\circ\text{C}$                                    | —   | 2    | 3   | mA                   |
| Bias current fluctuation to input       | $\Delta I_{\text{Bias(IN)}}$ | $V_1 = 11$ to 23V, $T_j = 25^\circ\text{C}$                 | —   | —    | 1   | mA                   |
| Bias current fluctuation to load        | $\Delta I_{\text{Bias(L)}}$  | $I_O = 1$ to 40mA, $T_j = 25^\circ\text{C}$                 | —   | —    | 0.1 | mA                   |
| Output noise voltage                    | $V_{\text{no}}$              | $f = 10\text{Hz}$ to 100kHz                                 | —   | 60   | —   | $\mu\text{V}$        |
| Ripple rejection ratio                  | RR                           | $V_1 = 11$ to 21V, $I_O = 40\text{mA}$ , $f = 120\text{Hz}$ | 44  | 54   | —   | dB                   |
| Minimum input/output voltage difference | $V_{\text{DIF(min)}}$        | $T_j = 25^\circ\text{C}$                                    | —   | 1.7  | —   | V                    |
| Output short-circuit current            | $I_{\text{O(Short)}}$        | $T_j = 25^\circ\text{C}$ , $V_1 = 35\text{V}$               | —   | 140  | —   | mA                   |
| Output voltage temperature coefficient  | $\Delta V_O/T_a$             | $I_O = 5\text{mA}$ , $T_j = 0$ to $125^\circ\text{C}$       | —   | -0.8 | —   | mV/ $^\circ\text{C}$ |

Note 1) The specified condition  $T_j = 25^\circ\text{C}$  means that the test should be carried out within so short a test time (within 10ms) that the characteristic value drift due to the chip junction temperature rise can be ignored.

Note 2) Unless otherwise specified,  $V_1 = 14\text{V}$ ,  $I_O = 40\text{mA}$ ,  $C_1 = 0.33\mu\text{F}$ ,  $C_O = 0.1\mu\text{F}$ ,  $T_j = 0$  to  $125^\circ\text{C}$  (AN78L08) and  $T_j = 0$  to  $100^\circ\text{C}$  (AN78L08M)

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### ■ Electrical Characteristics at $T_a = 25^\circ\text{C}$ (continued)

#### • AN78L09, AN78L09M (9V type)

| Parameter                               | Symbol                       | Conditions  | Min  | Typ   | Max  | Unit                       |
|---|------------------------------|---|------|-------|------|----------------------------|
| Output voltage                          | $V_O$                        | $T_j = 25^\circ\text{C}$                                    | 8.64 | 9     | 9.35 | V                          |
| Output voltage tolerance                | $V_O$                        | $V_I = 11.5$ to 24V, $I_O = 1$ to 70mA                      | 8.55 | —     | 9.45 | V                          |
| Line regulation                         | $\text{REG}_{\text{IN}}$     | $V_I = 11.5$ to 24V, $T_j = 25^\circ\text{C}$               | —    | 90    | 190  | mV                         |
|   |                              | $V_I = 12$ to 24V, $T_j = 25^\circ\text{C}$                 | —    | 80    | 140  | mV                         |
| Load regulation                         | $\text{REG}_{\text{L}}$      | $I_O = 1$ to 100mA, $T_j = 25^\circ\text{C}$                | —    | 16    | 85   | mV                         |
|   |                              | $I_O = 1$ to 40mA, $T_j = 25^\circ\text{C}$                 | —    | 8     | 45   | mV                         |
| Bias current                            | $I_{\text{Bias}}$            | $T_j = 25^\circ\text{C}$                                    | —    | 2     | 3    | mA                         |
| Bias current fluctuation to input       | $\Delta I_{\text{Bias(IN)}}$ | $V_I = 12$ to 24V, $T_j = 25^\circ\text{C}$                 | —    | —     | 1    | mA                         |
| Bias current fluctuation to load        | $\Delta I_{\text{Bias(L)}}$  | $I_O = 1$ to 40mA, $T_j = 25^\circ\text{C}$                 | —    | —     | 0.1  | mA                         |
| Output noise voltage                    | $V_{\text{no}}$              | $f = 10\text{Hz}$ to 100kHz                                 | —    | 65    | —    | $\mu\text{V}$              |
| Ripple rejection ratio                  | RR                           | $V_I = 12$ to 22V, $I_O = 40\text{mA}$ , $f = 120\text{Hz}$ | 43   | 53    | —    | dB                         |
| Minimum input/output voltage difference | $V_{\text{DIF(min)}}$        | $T_j = 25^\circ\text{C}$                                    | —    | 1.7   | —    | V                          |
| Output short-circuit current            | $I_{\text{O(Short)}}$        | $T_j = 25^\circ\text{C}$ , $V_I = 35\text{V}$               | —    | 140   | —    | mA                         |
| Output voltage temperature coefficient  | $\Delta V_O/T_a$             | $I_O = 5\text{mA}$ , $T_j = 0$ to $125^\circ\text{C}$       | —    | -0.85 | —    | $\text{mV}/^\circ\text{C}$ |

Note 1) The specified condition  $T_j = 25^\circ\text{C}$  means that the test should be carried out within so short a test time (within 10ms) that the characteristic value drift due to the chip junction temperature rise can be ignored.

Note 2) Unless otherwise specified,  $V_I = 15\text{V}$ ,  $I_O = 40\text{mA}$ ,  $C_I = 0.33\mu\text{F}$ ,  $C_O = 0.1\mu\text{F}$ ,  $T_j = 0$  to  $125^\circ\text{C}$  (AN78L09) and  $T_j = 0$  to  $100^\circ\text{C}$  (AN78L09M)

#### • AN78L10, AN78L10M (10V type)

| Parameter                               | Symbol                       | Conditions  | Min | Typ  | Max  | Unit                       |
|---|------------------------------|---|-----|------|------|----------------------------|
| Output voltage                          | $V_O$                        | $T_j = 25^\circ\text{C}$                                    | 9.6 | 10   | 10.4 | V                          |
| Output voltage tolerance                | $V_O$                        | $V_I = 12.5$ to 25V, $I_O = 1$ to 70mA                      | 9.5 | —    | 10.5 | V                          |
| Line regulation                         | $\text{REG}_{\text{IN}}$     | $V_I = 12.5$ to 25V, $T_j = 25^\circ\text{C}$               | —   | 100  | 210  | mV                         |
|   |                              | $V_I = 13$ to 25V, $T_j = 25^\circ\text{C}$                 | —   | 90   | 160  | mV                         |
| Load regulation                         | $\text{REG}_{\text{L}}$      | $I_O = 1$ to 100mA, $T_j = 25^\circ\text{C}$                | —   | 17   | 90   | mV                         |
|   |                              | $I_O = 1$ to 40mA, $T_j = 25^\circ\text{C}$                 | —   | 9    | 45   | mV                         |
| Bias current                            | $I_{\text{Bias}}$            | $T_j = 25^\circ\text{C}$                                    | —   | 2    | 3    | mA                         |
| Bias current fluctuation to input       | $\Delta I_{\text{Bias(IN)}}$ | $V_I = 13$ to 25V, $T_j = 25^\circ\text{C}$                 | —   | —    | 1    | mA                         |
| Bias current fluctuation to load        | $\Delta I_{\text{Bias(L)}}$  | $I_O = 1$ to 40mA, $T_j = 25^\circ\text{C}$                 | —   | —    | 0.1  | mA                         |
| Output noise voltage                    | $V_{\text{no}}$              | $f = 10\text{Hz}$ to 100kHz                                 | —   | 70   | —    | $\mu\text{V}$              |
| Ripple rejection ratio                  | RR                           | $V_I = 13$ to 23V, $I_O = 40\text{mA}$ , $f = 120\text{Hz}$ | 42  | 52   | —    | dB                         |
| Minimum input/output voltage difference | $V_{\text{DIF(min)}}$        | $T_j = 25^\circ\text{C}$                                    | —   | 1.7  | —    | V                          |
| Output short-circuit current            | $I_{\text{O(Short)}}$        | $T_j = 25^\circ\text{C}$ , $V_I = 35\text{V}$               | —   | 140  | —    | mA                         |
| Output voltage temperature coefficient  | $\Delta V_O/T_a$             | $I_O = 5\text{mA}$ , $T_j = 0$ to $125^\circ\text{C}$       | —   | -0.9 | —    | $\text{mV}/^\circ\text{C}$ |

Note 1) The specified condition  $T_j = 25^\circ\text{C}$  means that the test should be carried out within so short a test time (within 10ms) that the characteristic value drift due to the chip junction temperature rise can be ignored.

Note 2) Unless otherwise specified,  $V_I = 16\text{V}$ ,  $I_O = 40\text{mA}$ ,  $C_I = 0.33\mu\text{F}$ ,  $C_O = 0.1\mu\text{F}$ ,  $T_j = 0$  to  $125^\circ\text{C}$  (AN78L10) and  $T_j = 0$  to  $100^\circ\text{C}$  (AN78L10M)

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### ■ Electrical Characteristics at $T_a = 25^\circ\text{C}$ (continued)

#### • AN78L12, AN78L12M (12V type)

| Parameter                               | Symbol                       | Conditions  | Min  | Typ | Max  | Unit                       |
|---|------------------------------|---|------|-----|------|----------------------------|
| Output voltage                          | $V_O$                        | $T_j = 25^\circ\text{C}$  | 11.5 | 12  | 12.5 | V                          |
| Output voltage tolerance                | $V_O$                        | $V_I = 14.5$ to $27\text{V}$ , $I_O = 1$ to $70\text{mA}$             | 11.4 | —   | 12.6 | V                          |
| Line regulation                         | $\text{REG}_{\text{IN}}$     | $V_I = 14.5$ to $27\text{V}$ , $T_j = 25^\circ\text{C}$               | —    | 120 | 250  | mV                         |
|   |                              | $V_I = 15$ to $27\text{V}$ , $T_j = 25^\circ\text{C}$                 | —    | 100 | 200  | mV                         |
| Load regulation                         | $\text{REG}_{\text{L}}$      | $I_O = 1$ to $100\text{mA}$ , $T_j = 25^\circ\text{C}$                | —    | 20  | 100  | mV                         |
|   |                              | $I_O = 1$ to $40\text{mA}$ , $T_j = 25^\circ\text{C}$                 | —    | 10  | 50   | mV                         |
| Bias current                            | $I_{\text{Bias}}$            | $T_j = 25^\circ\text{C}$  | —    | 2   | 3.5  | mA                         |
| Bias current fluctuation to input       | $\Delta I_{\text{Bias(IN)}}$ | $V_I = 15$ to $27\text{V}$ , $T_j = 25^\circ\text{C}$                 | —    | —   | 1    | mA                         |
| Bias current fluctuation to load        | $\Delta I_{\text{Bias(L)}}$  | $I_O = 1$ to $40\text{mA}$ , $T_j = 25^\circ\text{C}$                 | —    | —   | 0.1  | mA                         |
| Output noise voltage                    | $V_{\text{no}}$              | $f = 10\text{Hz}$ to $100\text{kHz}$                                  | —    | 80  | —    | $\mu\text{V}$              |
| Ripple rejection ratio                  | RR                           | $V_I = 15$ to $25\text{V}$ , $I_O = 40\text{mA}$ , $f = 120\text{Hz}$ | 40   | 50  | —    | dB                         |
| Minimum input/output voltage difference | $V_{\text{DIF(min)}}$        | $T_j = 25^\circ\text{C}$  | —    | 1.7 | —    | V                          |
| Output short-circuit current            | $I_{\text{O(Short)}}$        | $T_j = 25^\circ\text{C}$ , $V_I = 35\text{V}$                         | —    | 140 | —    | mA                         |
| Output voltage temperature coefficient  | $\Delta V_O/T_a$             | $I_O = 5\text{mA}$ , $T_j = 0$ to $125^\circ\text{C}$                 | —    | -1  | —    | $\text{mV}/^\circ\text{C}$ |

Note 1) The specified condition  $T_j = 25^\circ\text{C}$  means that the test should be carried out within so short a test time (within 10ms) that the characteristic value drift due to the chip junction temperature rise can be ignored.

Note 2) Unless otherwise specified,  $V_I = 19\text{V}$ ,  $I_O = 40\text{mA}$ ,  $C_1 = 0.33\mu\text{F}$ ,  $C_O = 0.1\mu\text{F}$ ,  $T_j = 0$  to  $125^\circ\text{C}$  (AN78L12) and  $T_j = 0$  to  $100^\circ\text{C}$  (AN78L12M)

#### • AN78L15, AN78L15M (15V type)

| Parameter                               | Symbol                       | Conditions  | Min   | Typ  | Max   | Unit                       |
|---|------------------------------|---|-------|------|-------|----------------------------|
| Output voltage                          | $V_O$                        | $T_j = 25^\circ\text{C}$  | 14.4  | 15   | 15.6  | V                          |
| Output voltage tolerance                | $V_O$                        | $V_I = 17.5$ to $30\text{V}$ , $I_O = 1$ to $70\text{mA}$             | 14.25 | —    | 15.75 | V                          |
| Line regulation                         | $\text{REG}_{\text{IN}}$     | $V_I = 17.5$ to $30\text{V}$ , $T_j = 25^\circ\text{C}$               | —     | 130  | 300   | mV                         |
|   |                              | $V_I = 18$ to $30\text{V}$ , $T_j = 25^\circ\text{C}$                 | —     | 110  | 250   | mV                         |
| Load regulation                         | $\text{REG}_{\text{L}}$      | $I_O = 1$ to $100\text{mA}$ , $T_j = 25^\circ\text{C}$                | —     | 25   | 150   | mV                         |
|   |                              | $I_O = 1$ to $40\text{mA}$ , $T_j = 25^\circ\text{C}$                 | —     | 12   | 75    | mV                         |
| Bias current                            | $I_{\text{Bias}}$            | $T_j = 25^\circ\text{C}$  | —     | 2    | 3.5   | mA                         |
| Bias current fluctuation to input       | $\Delta I_{\text{Bias(IN)}}$ | $V_I = 18$ to $30\text{V}$ , $T_j = 25^\circ\text{C}$                 | —     | —    | 1     | mA                         |
| Bias current fluctuation to load        | $\Delta I_{\text{Bias(L)}}$  | $I_O = 1$ to $40\text{mA}$ , $T_j = 25^\circ\text{C}$                 | —     | —    | 0.1   | mA                         |
| Output noise voltage                    | $V_{\text{no}}$              | $f = 10\text{Hz}$ to $100\text{kHz}$                                  | —     | 90   | —     | $\mu\text{V}$              |
| Ripple rejection ratio                  | RR                           | $V_I = 18$ to $28\text{V}$ , $I_O = 40\text{mA}$ , $f = 120\text{Hz}$ | 38    | 48   | —     | dB                         |
| Minimum input/output voltage difference | $V_{\text{DIF(min)}}$        | $T_j = 25^\circ\text{C}$  | —     | 1.7  | —     | V                          |
| Output short-circuit current            | $I_{\text{O(Short)}}$        | $T_j = 25^\circ\text{C}$ , $V_I = 35\text{V}$                         | —     | 140  | —     | mA                         |
| Output voltage temperature coefficient  | $\Delta V_O/T_a$             | $I_O = 5\text{mA}$ , $T_j = 0$ to $125^\circ\text{C}$                 | —     | -1.3 | —     | $\text{mV}/^\circ\text{C}$ |

Note 1) The specified condition  $T_j = 25^\circ\text{C}$  means that the test should be carried out within so short a test time (within 10ms) that the characteristic value drift due to the chip junction temperature rise can be ignored.

Note 2) Unless otherwise specified,  $V_I = 23\text{V}$ ,  $I_O = 40\text{mA}$ ,  $C_1 = 0.33\mu\text{F}$ ,  $C_O = 0.1\mu\text{F}$ ,  $T_j = 0$  to  $125^\circ\text{C}$  (AN78L15) and  $T_j = 0$  to  $100^\circ\text{C}$  (AN78L15M)

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### ■ Electrical Characteristics at $T_a = 25^\circ\text{C}$ (continued)

#### • AN78L18, AN78L18M (18V type)

| Parameter                               | Symbol                       | Conditions  | Min  | Typ  | Max  | Unit                       |
|---|------------------------------|---|------|------|------|----------------------------|
| Output voltage                          | $V_O$                        | $T_j = 25^\circ\text{C}$  | 17.3 | 18   | 18.7 | V                          |
| Output voltage tolerance                | $V_O$                        | $V_I = 20.5$ to $33\text{V}$ , $I_O = 1$ to $70\text{mA}$             | 17.1 | —    | 18.9 | V                          |
| Line regulation                         | $\text{REG}_{\text{IN}}$     | $V_I = 20.5$ to $33\text{V}$ , $T_j = 25^\circ\text{C}$               | —    | 45   | 300  | mV                         |
|   |                              | $V_I = 21$ to $33\text{V}$ , $T_j = 25^\circ\text{C}$                 | —    | 35   | 250  | mV                         |
| Load regulation                         | $\text{REG}_{\text{L}}$      | $I_O = 1$ to $100\text{mA}$ , $T_j = 25^\circ\text{C}$                | —    | 30   | 170  | mV                         |
|   |                              | $I_O = 1$ to $40\text{mA}$ , $T_j = 25^\circ\text{C}$                 | —    | 15   | 85   | mV                         |
| Bias current                            | $I_{\text{Bias}}$            | $T_j = 25^\circ\text{C}$  | —    | 2    | 3.5  | mA                         |
| Bias current fluctuation to input       | $\Delta I_{\text{Bias(IN)}}$ | $V_I = 21$ to $33\text{V}$ , $T_j = 25^\circ\text{C}$                 | —    | —    | 1    | mA                         |
| Bias current fluctuation to load        | $\Delta I_{\text{Bias(L)}}$  | $I_O = 1$ to $40\text{mA}$ , $T_j = 25^\circ\text{C}$                 | —    | —    | 0.1  | mA                         |
| Output noise voltage                    | $V_{\text{no}}$              | $f = 10\text{Hz}$ to $100\text{kHz}$                                  | —    | 150  | —    | $\mu\text{V}$              |
| Ripple rejection ratio                  | RR                           | $V_I = 21$ to $31\text{V}$ , $I_O = 40\text{mA}$ , $f = 120\text{Hz}$ | 36   | 46   | —    | dB                         |
| Minimum input/output voltage difference | $V_{\text{DIF(min)}}$        | $T_j = 25^\circ\text{C}$  | —    | 1.7  | —    | V                          |
| Output short-circuit current            | $I_{\text{O(Short)}}$        | $T_j = 25^\circ\text{C}$ , $V_I = 35\text{V}$                         | —    | 140  | —    | mA                         |
| Output voltage temperature coefficient  | $\Delta V_O/T_a$             | $I_O = 5\text{mA}$ , $T_j = 0$ to $125^\circ\text{C}$                 | —    | -1.5 | —    | $\text{mV}/^\circ\text{C}$ |

Note 1) The specified condition  $T_j = 25^\circ\text{C}$  means that the test should be carried out within so short a test time (within 10ms) that the characteristic value drift due to the chip junction temperature rise can be ignored.

Note 2) Unless otherwise specified,  $V_I = 27\text{V}$ ,  $I_O = 40\text{mA}$ ,  $C_1 = 0.33\mu\text{F}$ ,  $C_O = 0.1\mu\text{F}$ ,  $T_j = 0$  to  $125^\circ\text{C}$  (AN78L18) and  $T_j = 0$  to  $100^\circ\text{C}$  (AN78L18M)

#### • AN78L20, AN78L20M (20V type)

| Parameter                               | Symbol                       | Conditions  | Min  | Typ  | Max  | Unit                       |
|---|------------------------------|---|------|------|------|----------------------------|
| Output voltage                          | $V_O$                        | $T_j = 25^\circ\text{C}$  | 19.2 | 20   | 20.8 | V                          |
| Output voltage tolerance                | $V_O$                        | $V_I = 22.5$ to $35\text{V}$ , $I_O = 1$ to $70\text{mA}$             | 19   | —    | 21   | V                          |
| Line regulation                         | $\text{REG}_{\text{IN}}$     | $V_I = 22.5$ to $35\text{V}$ , $T_j = 25^\circ\text{C}$               | —    | 50   | 300  | mV                         |
|   |                              | $V_I = 23$ to $35\text{V}$ , $T_j = 25^\circ\text{C}$                 | —    | 40   | 250  | mV                         |
| Load regulation                         | $\text{REG}_{\text{L}}$      | $I_O = 1$ to $100\text{mA}$ , $T_j = 25^\circ\text{C}$                | —    | 35   | 180  | mV                         |
|   |                              | $I_O = 1$ to $40\text{mA}$ , $T_j = 25^\circ\text{C}$                 | —    | 17   | 90   | mV                         |
| Bias current                            | $I_{\text{Bias}}$            | $T_j = 25^\circ\text{C}$  | —    | 2    | 3.5  | mA                         |
| Bias current fluctuation to input       | $\Delta I_{\text{Bias(IN)}}$ | $V_I = 23$ to $35\text{V}$ , $T_j = 25^\circ\text{C}$                 | —    | —    | 1    | mA                         |
| Bias current fluctuation to load        | $\Delta I_{\text{Bias(L)}}$  | $I_O = 1$ to $40\text{mA}$ , $T_j = 25^\circ\text{C}$                 | —    | —    | 0.1  | mA                         |
| Output noise voltage                    | $V_{\text{no}}$              | $f = 10\text{Hz}$ to $100\text{kHz}$                                  | —    | 170  | —    | $\mu\text{V}$              |
| Ripple rejection ratio                  | RR                           | $V_I = 23$ to $33\text{V}$ , $I_O = 40\text{mA}$ , $f = 120\text{Hz}$ | 34   | 44   | —    | dB                         |
| Minimum input/output voltage difference | $V_{\text{DIF(min)}}$        | $T_j = 25^\circ\text{C}$  | —    | 1.7  | —    | V                          |
| Output short-circuit current            | $I_{\text{O(Short)}}$        | $T_j = 25^\circ\text{C}$ , $V_I = 35\text{V}$                         | —    | 140  | —    | mA                         |
| Output voltage temperature coefficient  | $\Delta V_O/T_a$             | $I_O = 5\text{mA}$ , $T_j = 0$ to $125^\circ\text{C}$                 | —    | -1.7 | —    | $\text{mV}/^\circ\text{C}$ |

Note 1) The specified condition  $T_j = 25^\circ\text{C}$  means that the test should be carried out within so short a test time (within 10ms) that the characteristic value drift due to the chip junction temperature rise can be ignored.

Note 2) Unless otherwise specified,  $V_I = 29\text{V}$ ,  $I_O = 40\text{mA}$ ,  $C_1 = 0.33\mu\text{F}$ ,  $C_O = 0.1\mu\text{F}$ ,  $T_j = 0$  to  $125^\circ\text{C}$  (AN78L20) and  $T_j = 0$  to  $100^\circ\text{C}$  (AN78L20M)

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■ Electrical Characteristics at  $T_a = 25^\circ\text{C}$  (continued)

• AN78L24, AN78L24M (24V type)

| Parameter                               | Symbol                       | Conditions  | Min  | Typ | Max  | Unit                       |
|---|------------------------------|---|------|-----|------|----------------------------|
| Output voltage                          | $V_O$                        | $T_j = 25^\circ\text{C}$  | 23   | 24  | 25   | V                          |
| Output voltage tolerance                | $V_O$                        | $V_I = 26.5$ to $39\text{V}$ , $I_O = 1$ to $70\text{mA}$             | 22.8 | —   | 25.2 | V                          |
| Line regulation                         | REG <sub>IN</sub>            | $V_I = 26.5$ to $39\text{V}$ , $T_j = 25^\circ\text{C}$               | —    | 60  | 300  | mV                         |
|   |                              | $V_I = 27$ to $39\text{V}$ , $T_j = 25^\circ\text{C}$                 | —    | 50  | 250  | mV                         |
| Load regulation                         | REG <sub>L</sub>             | $I_O = 1$ to $100\text{mA}$ , $T_j = 25^\circ\text{C}$                | —    | 40  | 200  | mV                         |
|   |                              | $I_O = 1$ to $40\text{mA}$ , $T_j = 25^\circ\text{C}$                 | —    | 20  | 100  | mV                         |
| Bias current                            | $I_{\text{Bias}}$            | $T_j = 25^\circ\text{C}$  | —    | 2   | 3.5  | mA                         |
| Bias current fluctuation to input       | $\Delta I_{\text{Bias(IN)}}$ | $V_I = 27$ to $39\text{V}$ , $T_j = 25^\circ\text{C}$                 | —    | —   | 1    | mA                         |
| Bias current fluctuation to load        | $\Delta I_{\text{Bias(L)}}$  | $I_O = 1$ to $40\text{mA}$ , $T_j = 25^\circ\text{C}$                 | —    | —   | 0.1  | mA                         |
| Output noise voltage                    | $V_{\text{no}}$              | $f = 10\text{Hz}$ to $100\text{kHz}$                                  | —    | 200 | —    | $\mu\text{V}$              |
| Ripple rejection ratio                  | RR                           | $V_I = 27$ to $37\text{V}$ , $I_O = 40\text{mA}$ , $f = 120\text{Hz}$ | 34   | 44  | —    | dB                         |
| Minimum input/output voltage difference | $V_{\text{DIF(min)}}$        | $T_j = 25^\circ\text{C}$  | —    | 1.7 | —    | V                          |
| Output short-circuit current            | $I_{\text{O(Short)}}$        | $T_j = 25^\circ\text{C}$ , $V_I = 35\text{V}$                         | —    | 140 | —    | mA                         |
| Output voltage temperature coefficient  | $\Delta V_O/T_a$             | $I_O = 5\text{mA}$ , $T_j = 0$ to $125^\circ\text{C}$                 | —    | -2  | —    | $\text{mV}/^\circ\text{C}$ |

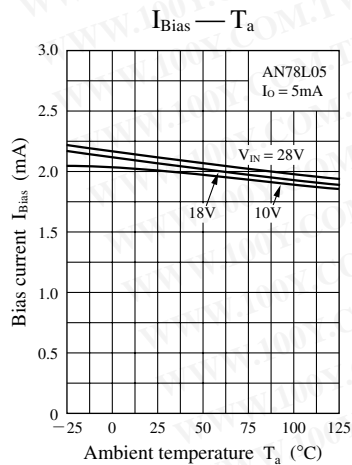
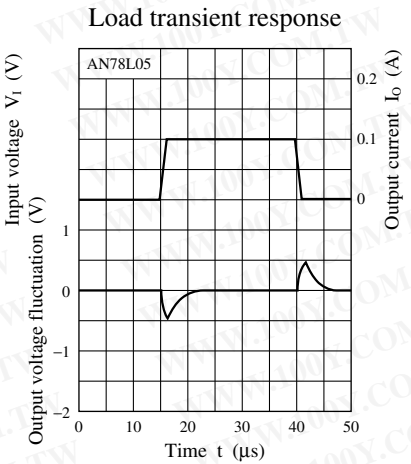
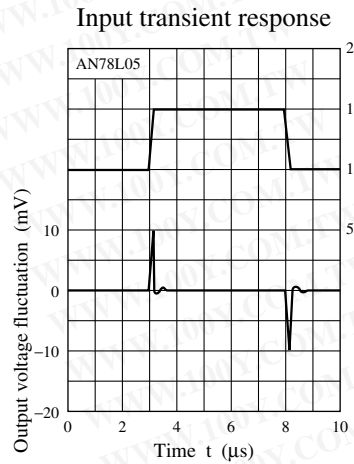
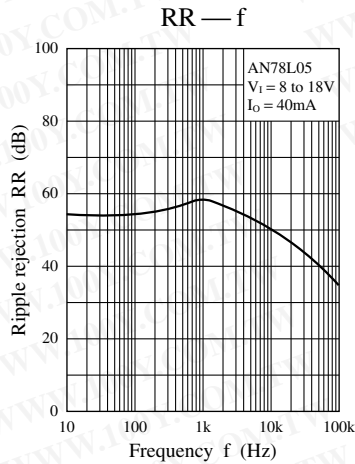
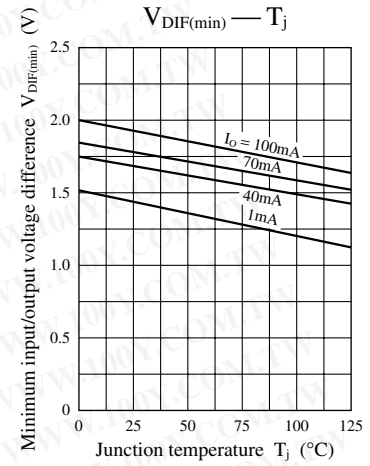
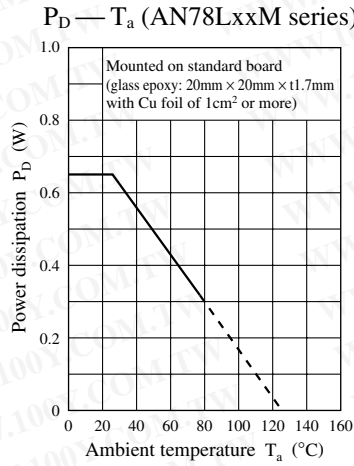
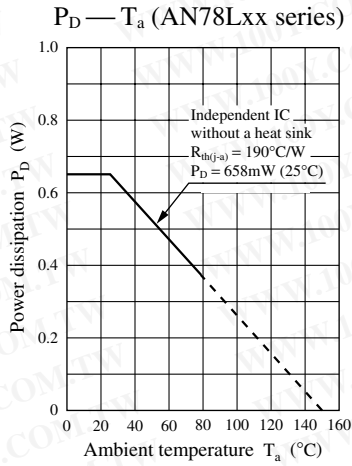
Note 1) The specified condition  $T_j = 25^\circ\text{C}$  means that the test should be carried out within so short a test time (within 10ms) that the characteristic value drift due to the chip junction temperature rise can be ignored.

Note 2) Unless otherwise specified,  $V_I = 33\text{V}$ ,  $I_O = 40\text{mA}$ ,  $C_I = 0.33\mu\text{F}$ ,  $C_O = 0.1\mu\text{F}$ ,  $T_j = 0$  to  $125^\circ\text{C}$  (AN78L24) and  $T_j = 0$  to  $100^\circ\text{C}$  (AN78L24M)

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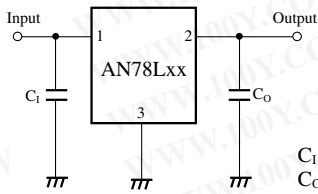


## Main Characteristics



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Basic Regulator Circuit



C<sub>1</sub> is necessary when the input line is long.  
C<sub>o</sub> improves the transient response.

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Usage Notes

1. Cautions for a basic circuit

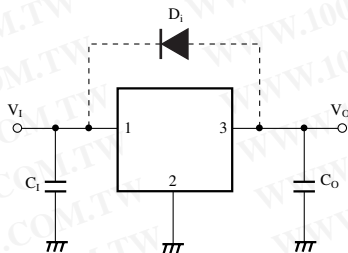


Figure 1

- C<sub>1</sub>: When a wiring from a smoothing circuit to a three-pin regulator is long, it is likely to oscillate at output. A capacitor of 0.1μF to 0.47μF should be connected near an input pin.
- C<sub>o</sub>: When any sudden change of load current is likely to occur, connect an electrolytic capacitor of 10μF to 100μF to improve a transitional response of output voltage.
- D<sub>1</sub>: Normally unnecessary. But add it in the case that there is a residual voltage at the output capacitor Co even after switching off the supply power because a current is likely to flow into an output pin of the IC and damage the IC.

2. Other caution items

1) Short-circuit between the input pin and GND pin

If the input pin is short-circuited to GND or is cut off when a large capacitance capacitor has been connected to the IC's load, a voltage of a capacitor connected to an output pin is applied between input/output of the IC and this likely results in damage of the IC. It is necessary, therefore, to connect a diode, as shown in figure 2, to counter the reverse bias between input/output pins.

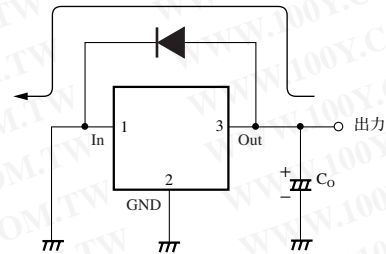
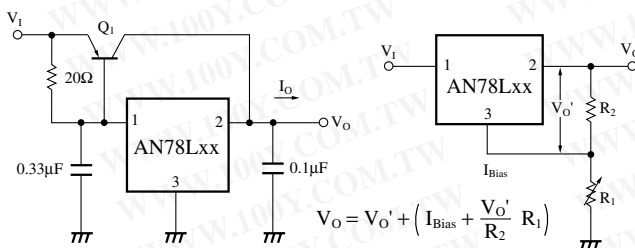


Figure 2

2) Floating of GND pin

If a GND pin is made floating in an operating mode, an unstabilized input voltage is outputted. In this case, a thermal protection circuit inside the IC does not normally operate. In this state, if the load is short-circuited or overloaded, it is likely to damage the IC.

Application Circuit Examples

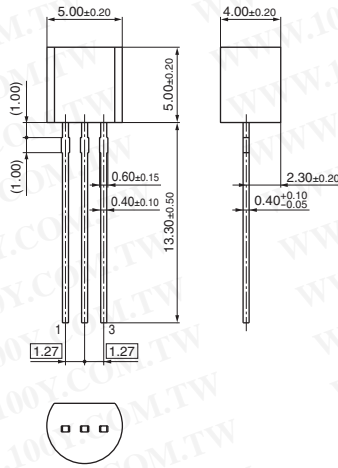


$$V_o = V_o' + \left( I_{Bias} + \frac{V_o'}{R_2} \right) R_1$$

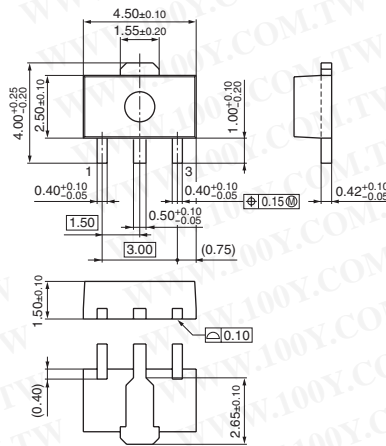
Note) V<sub>o</sub> varies due to sample to sample variation of I<sub>Bias</sub>.  
 Never fail to adjust individually with R<sub>1</sub>.

■ New Package Dimensions (Unit: mm)

- SSIP003-P-0000S (Lead-free package)



- HSIP003-P-0000Q (Lead-free package)



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